

<b>Notice of References Cited</b>	Application/Control No. 09/652,159	Applicant(s)/Patent Under Reexamination LIU ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0013815	01-2002	Obradovich et al.	709/204
*	B	US-2005/0261986	11-2005	Haynes et al.	705/026
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
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	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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